Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/913,454	CHEN ET AL.	
Examiner	Art Unit	
Minh Dieu Nauven	2137	

SEARCHED			
Class	Subclass	Date	Examiner
713	1-2, 100	7/13/2006	MDN
726	26	7/13/2006	MDN
380	155	7/13/2006	MDN

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated inventor name search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	7/13/2006	MDN
Updated text and class search on EAST (US-PAT; US-PG-PUB; EPO; JPO; DERWENT; IBM-TDB)	7/13/2006	MDN
Consulted with G. Barron on addressing applicant's remarks	7/13/2006	MDN
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